

Notice of References Cited

Application/Control No.

10/787,120

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

Chuong A. Luu

Art Unit

2892

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,884,699	04-2005	Ogawa et al.	438/166
*	B	US-6,861,614	03-2005	Tanabe et al.	219/121.66
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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